



т	EST REPOR	т				
For GSM900/DCS1800						
Report Reference No	TRE1603019101	R/C: 14043				
Applicant's name:	Vonino Electronics Limited	1				
Address	Miramar Tower 10F - no1010 Kowloon, Hong Kong	0, 132 Nathan Road, Tsim Sha Tsui,				
Manufacturer	Vonino Electronics Limited					
Address	Miramar Tower 10F - no1010 Kowloon, Hong Kong), 132 Nathan Road, Tsim Sha Tsui,				
Test item description:	XAVY L8 / Epic M8					
Trade Mark:	vonino					
Model/Type reference:	T8S					
Listed Model(s)						
Standard:	ETSI EN 301 511 V9.0.2: 20	03-03				
Date of receipt of test sample:	Mar 29, 2016					
Date of testing	Mar 30, 2016- Apr 20, 2016					
Date of issue:	Apr 20, 2016					
Result	PASS					
Compiled by (position+printed name+signature):	File administrators Shayne Z	hu Shayne Zhu				
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Approved by		House yes				
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Testing Laboratory Name:	Shenzhen Huatongwei Inte	rnational Inspection Co., Ltd				
Address:	1/F, Bldg 3, Hongfa Hi-tech lu Gongming, Shenzhen, China	ndustrial Park, Genyu Road, Tianliao, a				
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The test report merely corresponds to the test sample. It is not permitted to copy extracts of these test result without the written permission of the test laboratory.

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1. Test standards and Test description

1.1. Test Standards

The tests were performed according to following standards:

ETSI EN 301 511 V9.0.2 (2003-03)–Global System for Mobile communications (GSM);Harmonized EN for mobile stations in the GSM 900 and GSM 1800 bandscovering essential requirements underarticle 3.2 of the R&TTE directive (1999/5/EC)

ETSI TS 151 010-1 V10.2.0 (2012-10)–Digital cellular telecommunications system (Phase 2+); Mobile Station (MS) conformance specification; Part 1: Conformance specification (3GPP TS 51.010-1 version 10.2.0 Release 10)

<u>3GPP TS 51.010-1 version 10.2.0 Release 10</u>–Digital cellular telecommunications system (Phase 2+);Mobile Station (MS) conformance specification; Part 1: Conformance specification(3GPP TS 51.010-1 version 10.0.0 Release 10

1.2. Test Description

Radio Spectrum Matter (RSM) Part of Transmitter				
Test Item	Test require	Result		
Transmitter – Frequency error and phase error	Clause 4.2.1	Pass		
Transmitter – Frequency error under multi path and interference conditions	Clause 4.2.2	Pass		
Transmitter output power and burst timing	Clause 4.2.5	Pass		
Transmitter - Output RF spectrum	Clause 4.2.6	Pass		
Frequency error and phase error in GPRS multislot configuration	Clause 4.2.4	Pass		
Transmitter output power in GPRS multislot configuration	Clause 4.2.10	Pass		
Output RF spectrum in GPRS multislot configuration	Clause 4.2.11	Pass		
Frequency error and Modulation accuracy in EGPRS Configuration	Clause 4.2.22	Pass		
Frequency error under multipath and interference conditions in EGPRS Configuration	Clause 4.2.23	Pass		
EGPRS Transmitter output power	Clause 4.2.24	Pass		
Output RF spectrum in EGPRS configuration	Clause 4.2.25	Pass		
Conducted spurious emissions - MS allocated a channel	Clause 4.2.12	Pass		
Conducted spurious emissions - MS in idle mode	Clause 4.2.13	Pass		
Radiated spurious emissions - MS allocated a channel	Clause 4.2.16	Pass		
Radiated spurious emissions - MS in idle mode	Clause 4.2.17	Pass		
Radio Spectrum Matter (F	RSM) Part of Receiver			
Test Item	Test Method	Result		
Receiver Blocking and spurious response -speech channels	Clause 4.2.20	Pass		
Blocking and spurious response in EGPRS configuration	Clause 4.2.26	Pass		

Remark: The measurement uncertainty is not included in the test result.

2. <u>Summary</u>

2.1. Client Information

Applicant:	Vonino Electronics Limited
Address:	Miramar Tower 10F - no1010, 132 Nathan Road, Tsim Sha Tsui, Kowloon, Hong Kong
Manufacturer:	Vonino Electronics Limited
Address:	Miramar Tower 10F - no1010, 132 Nathan Road, Tsim Sha Tsui, Kowloon, Hong Kong

2.2. Product Description

Name of EUT:	ame of EUT: XAVY L8 / Epic M8	
Trade Mark:	vonino	
Model/Type reference:	T8S	
Listed Model(s):	-	
Power supply:	DC 3.7V From internal battery	
Adapter information:	Model:FJ-SW728L0502000UE	
	Input:AC 100-240V,50/60Hz 0.4A Max	
	Output: 5Vd.c., 2000mA	
2G		
Operation Band:	GSM900,DCS1800	
Supported type:	GSM/GPRS/EGPRS	
Operation Frequency Range:	Transmit: GSM900: 880.2MHz~914.8MHz DCS1800: 1710.2MHz~1784.8MHz Receive: GSM900: 925.2MHz~959.8MHz DCS1800: 1805.2MHz~1879.8MHz	
Power Class:	GSM900:Power Class 4 DCS1800:Power Class 1	
Modilation Type:	GMSK for GSM/GPRS GMSK, 8PSK for EGPRS	
GSM Release Version	R99	
GPRS Multislot Class	12	
EGPRS Multislot Class	12	
Hardware version:	V1.1	
Software version:	vonino_v1.1.2	
Antenna type:	Internal Antenna	
Antenna gain:	GSM900:1dBi DCS1800:1dBi	

Operation Frequency List:

Transmit Frequency Range				
	GSM900		DCS1800	
Channel	Frequency (MHz)	Channel	Frequency (MHz)	
975	880.20	512	1710.20	
976	880.40	513	1710.40	
:	÷	:	:	
61	902.20	697	1747.20	
62	902.40	698	1747.40	
63	902.60	699	1747.60	
:	:	:	÷	
123	914.60	884	1784.60	
124	914.80	885	1784.80	

2.3. EUT operation mode

The EUT and test equipment were configured for testing according to ETSI EN 301 511 V9.0.2 (2003-03), where refer to ETSI TS 151 010-1 V10.2.0 (2012-10) for details.

All the tests are performed at each SIM card mode, the datum recorded is the worst case for all the mode at SIM1 Card mode.

2.4. EUT configuration

The following peripheral devices and interface cables were connected during the measurement:

supplied by the manufacturer

Ο	- supplied	by the lab
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Length (m) :	/
Shield :	/
Detachable :	/
Manufacturer :	1
Model No. :	/

2.5. Modifications

No modifications were implemented to meet testing criteria.

3. Test Environment

4. est Environment

4.1. Address of the test laboratory

Laboratory:Shenzhen Huatongwei International Inspection Co., Ltd. Address: 1/F, Bldg 3, Hongfa Hi-tech Industrial Park, Genyu Road, Tianliao, Gongming, Shenzhen, China Phone: 86-755-26748019 Fax: 86-755-26748089

4.2. Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

CNAS-Lab Code: L1225

Shenzhen Huatongwei International Inspection Co., Ltd. has been assessed and proved to be in compliance with CNAS-CL01 Accreditation Criteria for Testing and Calibration Laboratories (identical to ISO/IEC17025: 2005 General Requirements) for the Competence of Testing and Calibration Laboratories, Date of Registration: February 28, 2015. Valid time is until February 27, 2018.

A2LA-Lab Cert. No. 3902.01

Shenzhen Huatongwei International Inspection Co., Ltd. EMC Laboratory has been accredited by A2LA for tec hnical competence in the field of electrical testing, and proved to be in compliance with ISO/IEC 17025: 2005 General Requirements for the Competence of Testing and Calibration Laboratories and any additional progra m requirements in the identified field of testing. Valid time is until December 31, 2016.

FCC-Registration No.: 317478

Shenzhen Huatongwei International Inspection Co., Ltd. EMC Laboratory has been registered and fully described in a report filed with the FCC (Federal Communications Commission). The acceptance letter from the FC C is maintained in our files. Registration 317478, Renewal date Jul. 18, 2014, valid time is until Jul. 18, 2017.

IC-Registration No.: 5377A&5377B

The 3m Alternate Test Site of Shenzhen Huatongwei International Inspection Co., Ltd. has been registered by Certification and Engineering Bureau of Industry Canada for the performance of radiated measurements with Registration No. 5377A on Dec. 31, 2013, valid time is until Dec. 31, 2016.

Two 3m Alternate Test Site of Shenzhen Huatongwei International Inspection Co., Ltd. has been registered by Certification and Engineering Bureau of Industry Canada for the performance of radiated measurements with Registration No. 5377B on Dec.03, 2014, valid time is until Dec.03, 2017.

ACA

Shenzhen Huatongwei International Inspection Co., Ltd. EMC Laboratory can also perform testing for the Aust ralian C-Tick mark as a result of our A2LA accreditation.

VCCI

The 3m Semi-

anechoic chamber (12.2m×7.95m×6.7m) of Shenzhen Huatongwei International Inspection Co., Ltd.

has been registered in accordance with the Regulations for Voluntary Control Measures with Registration No.: R-2484. Date of Registration: Dec. 20, 2012. Valid time is until Dec. 29, 2015.

Radiated disturbance above 1GHz measurement of Shenzhen Huatongwei International Inspection Co., Ltd. h as been registered in accordance with the Regulations for Voluntary Control Measures with Registration No.: G-292. Date of Registration: Dec. 24, 2013. Valid time is until Dec. 23, 2016.

Main Ports Conducted Interference Measurement of Shenzhen Huatongwei International Inspection Co., Ltd. has been registered in accordance with the Regulations for Voluntary Control Measures with Registration No.: C-2726. Date of Registration: Dec. 20, 2012. Valid time is until Dec. 19, 2015.

Telecommunication Ports Conducted Interference Measurement of Shenzhen Huatongwei International Inspection Co., Ltd. has been registered in accordance with the Regulations for Voluntary Control Measures with R egistration No.: T-1837. Date of Registration: May 07, 2013. Valid time is until May 06, 2016.

DNV

Shenzhen Huatongwei International Inspection Co., Ltd. has been found to comply with the requirements of D NV towards subcontractor of EMC and safety testing services in conjunction with the EMC and Low voltage Di rectives and in the voluntary field. The acceptance is based on a formal quality Audit and follow-

ups according to relevant parts of ISO/IEC Guide 17025 (2005), in accordance with the requirements of the D NV Laboratory Quality Manual towards subcontractors. Valid time is until Aug. 24, 2016.

4.3. Environmental conditions

During the measurement the environmental conditions were within the listed ranges:

	NT: Normal Temperature	25°C
Temperature	HT: High Temperature	55°C
	LV: Low Temperature	-10°C
	NV: Normal Voltage	DC 3.70V
Voltage	HV: High Voltage	DC 4.25V
	LV: Low Voltage	DC 3.50V
Other	lative Humidity	55 %
Other	Air Pressure	989 hPa

4.4. Statement of the measurement uncertainty

The data and results referenced in this document are true and accurate. The reader is cautioned that there may be errors within the calibration limits of the equipment and facilities. The measurement uncertainty was calculated for all measurements listed in this test report acc. to TR-100028-01" Electromagnetic compatibility and Radio spectrum Matters (ERM);Uncertainties in the measurement of mobile radio equipment characteristics;Part 1" and TR-100028-02 "Electromagnetic compatibilityand Radio spectrum Matters (ERM);Uncertainties in the measurement of mobile radio equipment characteristics;Part 2 " and is documented in the Shenzhen Huatongwei International Inspection Co., Ltd quality system acc. to DIN EN ISO/IEC 17025. Furthermore, component and process variability of devices similar to that tested may result in additional deviation. The manufacturer has the sole responsibility of continued compliance of the device.

ŀ	Hereafter the best mea	asurement capabilit	ty for S	Shenzhen I	Huatongwei	laboratory	is reported	:t

3GPP TS 51.010-1	Test Description	Uncertainty
12.1.1	Conducted spurious emissions-MS Allocated a Channel	
	Emissions@100kHz <f<2ghz< td=""><td>0.593dB</td></f<2ghz<>	0.593dB
	Emissions@2GHz <f<12.75ghz< td=""><td>1.123 dB</td></f<12.75ghz<>	1.123 dB
12.1.2	Conducted spurious emissions- MS in Idle Mode	
	Emissions@100kHz <f<2ghz< td=""><td>0.649 dB</td></f<2ghz<>	0.649 dB
	Emissions@2GHz <f<12.75ghz< td=""><td>1.123 dB</td></f<12.75ghz<>	1.123 dB
12.2.1	Radiated spurious emissions	2.2dB
12.2.2		
13.1	Frequency error and phase error	Freq
13.2	Frequency error under multipath and interference conditions	Err<11.5Hz
13.16.1	Frequency error and phase error in GPRS multislot configuration	RMS Phase
13.17.1	Frequency error and Modulation accuracy in EGPRS	Err 1.0degrees
13.17.2	Configuration	Peak Phase
	Frequency error under multipath and	Error
	interference conditions in EGPRS	4.0degrees
	Configuration	
13.3.4.1	Transmitter output power and burst timing	0.593dB
13.16.2.4.1	Transmitter output power in GPRS multislot configuration	
13.17.3.4.1	EGPRS Transmitter output power	
13.4	Output RF spectrum	0.593dB
13.16.3	Transmitter output power in GPRS(or EGPRS)multislot	
13.17.4	configuration	
14.7.1	Receiver Blocking and spurious response -	
14.18.5	speech channels	
	Blocking and spurious response in EGPRS	
	Configuration	
	Wanted Signal@f<2GHz	0.649 dB
	Blocking Signal@100kHz <f<2ghz< td=""><td>0.593 dB</td></f<2ghz<>	0.593 dB
	Blocking Signal@2GHz <f<12.75ghz< td=""><td>1.035 dB</td></f<12.75ghz<>	1.035 dB

This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=1.96.

4.5. Equipments Used during the Test

TS 8980-PRE						
Item	Test Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Next Cal.
1	WIDEB.RADIO COMM.TESRER	R&S	CMW500	1201.0002K50	2015/11/3	2016/11/2
2	AVG Power Sensor	R&S	NRP-Z31	1169.2400.02	2015/11/3	2016/11/2
3	VECTOR SIGNAL GENNERATOR	R&S	SMW200A	1412.0000K02	2015/11/3	2016/11/2
4	SIGNAL& SPECTRUM ANALYZER	R&S	FSW26	1312.8000K26	2015/11/3	2016/11/2
5	WIDEBAND FILTER UNIT	R&S	TS-TUFI1	1521.0000.03	2015/11/3	2016/11/2
c	SIGNA SWITCHING	DVC	SSCU-PRE1	1518.0026.12	2015/11/2	2016/11/2
0	UNIT	RAJ	SSCU-UPG4	1518.0732.02	2010/11/3	2010/11/2
7	POWER SUPPLY	R&S	NGMO1	1504.8420.03	2015/11/3	2016/11/2
5	Climate Chamber	ESPEC	EL-10KA	05107008	2015/11/3	2016/11/2

Radia	Radiated Emission/ Radiated power						
Item	Test Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Next Cal.	
1	Ultra-Broadband Antenna	SCHWARZB ECK	VULB9163	546	11/8/2014	11/7/2017	
2	Double-Ridged- Waveguide Horn Antenna	SCHWARZB ECK	9120D	1011	11/8/2014	11/7/2017	
3	Spectrum Analyzer	R&S	FSP40	100597	11/3/2015	11/2/2016	
4	Pre-amplifer	SCHWARZB ECK	BBV 9743	9743-0022	11/3/2015	11/2/2016	
5	Broadband Preamplifer	SCHWARZB ECK	BBV 9718	9718-248	11/3/2015	11/2/2016	
6	Turntable	Maturo Germany	TT2.0-1T	\	N/A	N/A	
7	Antenna Mast	Maturo Germany	CAM-4.0-P- 12	\	N/A	N/A	
8	Test Software	R&S	ES-K1	/	N/A	N/A	
9	WIDEB.RADIO COMM.TESRER	R&S	CMW500	1201.0002K50	2015/11/3	2016/11/2	

The Cal. Interval was one year

5. <u>Test conditions and Results</u>

Test Item	Test Requirement	Test Method	Test	Verdict		Noto:	
restitem	ESTI EN301 511	ETSI TS151010-1	Conditions	GSM900	DCS1800	Note.	
			NT/NV	Pass	Pass		
			LT/LV	Pass	Pass		
Transmitter -			LT/HV	Pass	Pass		
Frequency error	Section 4.2.1	Clause 13.1	HT/LV	Pass	Pass		
and phase error			HT/HV	Pass	Pass		
			Vibrated X/Y/Z	Pass	Pass		
Transmitter -			NT/NV	Pass	Pass		
Frequency error			LT/LV	Pass	Pass		
under multipath	Section 4.2.2	Clause 13.2	LT/HV	Pass	Pass		
and interference			HT/LV	Pass	Pass		
conditions			HT/HV	Pass	Pass		
			NT/NV	Pass	Pass		
Transmitter			LT/LV	Pass	Pass	Reference	
output power	Section 4.2.5	Clause 13.3	LT/HV	Pass	Pass	to section	
and burst timing			HT/LV	Pass	Pass	4.1	
			HT/HV	Pass	Pass		
			NT/NV	Pass	Pass		
Transmitter -			LT/LV	Pass	Pass		
Output RF	Section 4.2.6	Clause 13.4	LT/HV	Pass	Pass		
spectrum			HT/LV	Pass	Pass		
			HT/HV	Pass	Pass		
Conducted			NT/NV	Pass	Pass		
spurious	.		NT/LV	Pass	Pass		
emissions - MS allocated a channel	Section 4.2.12	Clause 12.1.1	NT/HV	Pass	Pass		
Conducted			NT/NV	Pass	Pass		
spurious	Section 4.2.13	Clause 12.1.2	NT/LV	Pass	Pass		
in idle mode			NT/HV	Pass	Pass		
Radiated			NT/NV	Pass	Pass		
spurious	Section 4.2.16		NT/LV	Pass	Pass	Reference	
allocated a channel		Clause 12.2.1	NT/HV	Pass	Pass	10 section 4.4	
Radiated			NT/NV	Pass	Pass		
spurious	Section 4.2.17	Clause 12.2.2	NT/LV	Pass	Pass	Reterence to section	
emissions - MS in idle mode			NT/HV	Pass	Pass	4.5	
Receiver Blocking and spurious response - speech channels	Section 4.2.20	Clause 14.7.1	NT/NV	Pass	Pass		

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—	Test Requirement	Test Method	Test	Ve	rdict	N 1 <i>i</i>
l est Item	ESTI EN301 511	ETSI TS151010-1	Conditions	GPRS900	GPRS1800	Note:
			NT/NV	Pass	Pass	
F			LT/LV	Pass	Pass	
Frequency error			LT/HV	Pass	Pass	
in GPRS multislot	Section 4.2.4	Clause 13.16.1	HT/LV	Pass	Pass	
configuration			HT/HV	Pass	Pass	
			Vibrated X/Y/Z	Pass	Pass	
Transmitter			NT/NV	Pass	Pass	
output power in			LT/LV	Pass	Pass	Reference
GPRS multislot	Section 4.2.10	Clause 13.16.2	LT/HV	Pass	Pass	to section
configuration			HT/LV	Pass	Pass	4.2
			HT/HV	Pass	Pass	
			NT/NV	Pass	Pass	
spectrum in			LT/LV	Pass	Pass	
GPRS multislot	Section 4.2.11	Clause 13.16.3	LT/HV	Pass	Pass	
configuration			HT/LV	Pass	Pass	
			HT/HV	Pass	Pass	
Teet litere	Test Requirement	Test Method	Test	Ve	rdict	Nata
l est item	ESTI EN301 511	ETSI TS151010-1	Conditions	EGPRS900	EGPRS1800	Note:
Eroquoney error			NT/NV	Pass	Pass	
and Modulation			LT/LV	Pass	Pass	
accuracy in	Section 4.2.22	Clause 13.17.1	LT/HV	Pass	Pass	
EGPRS			HT/LV	Pass	Pass	
Configuration			HT/HV	Pass	Pass	
Frequency error			NT/NV	Pass	Pass	
under multipath			LT/LV	Pass	Pass	
and interference	Section 4.2.23	Clause 13.17.2	LT/HV	Pass	Pass	
EGPRS			HT/LV	Pass	Pass	
Configuration			HT/HV	Pass	Pass	
_			NT/NV	Pass	Pass	
FGPRS			LT/LV	Pass	Pass	Poforonco
Transmitter	Section 4.2.24	Clause 13.17.3	LT/HV	Pass	Pass	to section
output power			HT/LV	Pass	Pass	4.3
			HT/HV	Pass	Pass	
			NT/NV	Pass	Pass	
Output RF			LT/LV	Pass	Pass	
spectrum in	Section 4.2.25	Clause 13.17.4	LT/HV	Pass	Pass	
EGPRS			HT/LV	Pass	Pass	
conngulation			HT/HV	Pass	Pass	
Blocking and spurious response in EGPRS configuration	Section 4.2.26	Clause 14.18.5	NT / NV	Pass	Pass	

5.1. Transmitter output power and burst timing

<u>LIMIT</u>

ETSI TS 51.010-1 Sub-clause 13.3.5

The transmitter output power is the average value of the power delivered to an artificial antenna or radiated by the MS and its integral antenna, over the time that the useful information bits of one burst are transmitted. The transmit burst timing is the envelope of the RF power transmitted with respect to time. The timings are referenced to the transition from bit 13 to bit 14 of the Training Sequence ("midamble") before differential decoding. The timing of the modulation is referenced to the timing of the received signal from the SS.

The transmitter output power, under every combination of normal and extreme test conditions, for normal bursts and access bursts, at each frequency and for each nominal output power level applicable to the MS power class, shall be at the relevant level shown in table 13-2, table 13-3 within the tolerances also shown in table 13-2, table 13-3

Power class		Power control	Transmitter	Toler	ances			
		level (note2)	output power					
2	3	4	5		dBm	normal	extreme	
•				2	39	±2 dB	±2,5 dB	
•	•			3	37	±3 dB (note1)	±4 dB (note1)	
·	•			4	35	±3 dB	±4 dB	
·	•	•		5	33	±3 dB (note1)	±4 dB (note1)	
·	•	•		6	31	±3 dB	±4 dB	
·	•	•	·	7	29	±3 dB (note1)	±4 dB (note1)	
· ·	•	•	•	8	27	±3 dB	±4 dB	
· ·	•	•	•	9	25	±3 dB	±4 dB	
•	•	•	•	10	23	±3 dB	±4 dB	
•	•	•	•	11	21	±3 dB	±4 dB	
•	•	•	•	12	19	±3 dB	±4 dB	
•	•	•	•	13	17	±3 dB	±4 dB	
·	•	•	•	14	15	±3 dB	±4 dB	
·	•	•	•	15	13	±3 dB	±4 dB	
•	•	•	•	16	11	±5 dB	±6 dB	
·	•	•	·	17	9	±5 dB	±6 dB	
·	•	•	•	18	7	±5 dB	±6 dB	
•	•	•	•	19	5	±5 dB	±6 dB	
NOT	E1:	Whe	n the	power control leve	el corresponds to	the power class o	f the MS, then	
		the tolerances shall be 2,0 dB under normal test conditions and 2,5 dB under						
		extre	eme te	est conditions.				
NOTE2: There is no requirement to test power control levels 20-31								

Pov	Power class		Power control	Transmitter	Tolerances	
1	2	3	lever (notez)	dBm	normal	extreme
		•	29	36	±2,0 dB	±2,5 dB
		•	30	34	±3,0 dB	±4,0 dB
		•	31	32	±3,0 dB	±4,0 dB
·		•	0	30	±3,0 dB (note1)	±4 dB (note1)
•		•	1	28	±3 dB	±4 dB
•		•	2	26	±3 dB	±4 dB
•	•	•	3	24	±3 dB (note1)	±4 dB (note1)
•	•	•	4	22	±3 dB	±4 dB
•	•	•	5	20	±3 dB	±4 dB
•	•	•	6	18	±3 dB	±4 dB
•	•	•	7	16	±3 dB	±4 dB
•	•	•	8	14	±3 dB	±4 dB
•	•	•	9	12	±4 dB	±5 dB
•	•	•	10	10	±4 dB	±5 dB
•	•	•	11	8	±4 dB	±5 dB
•	•	•	12	6	±4 dB	±5 dB
•	•	•	13	4	±4 dB	±5 dB
•	•	•	14	2	±5 dB	±6 dB
•	•	•	15	0	±5 dB	±6 dB
NOTE1: When the power control level corresponds to the power class of the MS, then the tolerances shall be 2,0 dB under normal test conditions and 2,5 dB under extreme test conditions.						
NOTE2: There is no requirement to test power control levels 16-28						

TEST PROCEDURE

ETSI TS 51.010-1 Sub-clause 13.3.4.2

- a) Measurement of normal burst transmitter output power.
 - 1. The SS takes power measurement samples evenly distributed over the duration of one burst with a sampling rate of at least 2/T, where T is the bit duration. The samples are identified in time with respect to the modulation on the burst. The SS identifies the centre of the useful 147 transmitted bits, i.e. the transition from bit 13 to bit 14 of the midamble, as the timing reference.
 - 2. The transmitter output power is calculated as the average of the samples over the 147 useful bits. This is also used as the 0 dB reference for the power/time template.
- b) Measurement of normal burst timing delay. The burst timing delay is the difference in time between the timing reference identified in a) and the corresponding transition in the burst received by the MS immediately prior to the MS transmit burst sampled.
- Measurement of normal burst power/time relationship.
 The array of power samples measured in a) are referenced in time to the centre of the useful transmitted bits and in power to the 0 dB reference, both identified in 1.
- d) Steps 1 to 3 are repeated with the MS commanded to operate on each of the nominal output power levels supported by the MS, (see tables 13-2, 13-3 and 13-4) and in step a) on one nominal output power level higher than supported by the MS.
- e) The SS commands the MS to the maximum power control level supported by the MS and steps 1) to 2 are repeated for ARFCN in the Low and High ranges.
- f) Measurement of access burst transmitter output power.
 - The SS causes the MS to generate an Access Burst on an ARFCN in the Mid ARFCN range, this could be either by a handover procedure or a new request for radio resource. In the case of a handover procedure the Power Level indicated in the HANDOVER COMMAND message is the maximum power control level supported by the MS. In the case of an Access Burst the MS shall use the Power Level indicated in the MS_TXPWR_MAX_CCH parameter. If the power class of the MS is DCS 1 800 Class 3, the MS shall also use the POWER_OFFSET parameter.
 - 2. The SS takes power measurement samples evenly distributed over the duration of the access burst as described in a). However, in this case the SS identifies the centre of the useful bits of the burst by identifying the transition from the last bit of the synch sequence. The centre of the burst is then five data bits prior to this point and is used as the timing reference.

- 3. The transmitter output power is calculated as the average of the samples over the 87 useful bits of the burst. This is also used as the 0 dB reference for the power/time template.
- g) Measurement of access burst timing delay. The burst timing delay is the difference in time between the timing reference identified in f) and the MS received data on the common control channel.
- h) Measurement of access burst power/time relationship.
 The array of power samples measured in f) is referenced in time to the centre of the useful transmitted bits and in power to the 0 dB reference, both identified in 6.
- i) Depending on the method used in step f) to cause the MS to send an Access Burst, the SS sends either a HANDOVER COMMAND with power control level set to 10 or it changes the System Information elements MS_TXPWR_MAX_CCH and for DCS 1 800 the POWER_OFFSET on the serving cell BCCH in order to limit the MS transmit power on the Access Burst to power control level 10 (+23 dBm for GSM 400, GSM 700, T-GSM 810, GSM 850, and GSM 900 or +10 dBm for DCS 1 800 and PCS 1 900) and then steps6 to 8 are repeated.
- j) Steps1 to 8 are repeated under extreme test conditions (annex 1, TC2.2) except that the repeats at step 4 are only performed for power control level 10 and the minimum nominal output power level supported by the MS.

TEST RESULTS

Report No : TRE1603019101

GSM900						
Test envi	ronment	Device control	Output Power (dBm)			
Temperature (℃)	Voltage (V)	Level	CH975	CH62	CH124	
		5	32.85	32.47	32.93	
25	3.70	12	19.86	19.67	19.25	
		19	5.64	5.75	5.74	
		5	32.99	32.56	33.05	
	4.25	12	19.99	19.75	19.36	
10		19	5.75	5.82	5.83	
-10	3.50	5	32.95	32.53	33.02	
		12	19.96	19.73	19.33	
		19	5.73	5.81	5.82	
		5	32.73	32.40	32.83	
	4.25	12	19.76	19.61	19.17	
155		19	5.55	5.69	5.66	
+55		5	32.68	32.37	32.79	
	3.50	12	19.71	19.57	19.12	
		19	5.50	5.66	5.62	

DCS1800						
Test envi	ronment		Output Power (dBm)			
Temperature (℃)	Voltage (V)	Level	CH512	CH698	CH885	
		0	29.85	29.74	29.76	
25	3.70	8	14.52	15.36	15.08	
		15	1.62	1.25	1.43	
	4.25	0	30.02	29.85	29.91	
		8	14.68	15.46	15.22	
10		15	1.76	1.34	1.55	
-10	3.50	0	29.98	29.82	29.87	
		8	14.64	15.44	15.18	
		15	1.73	1.32	1.53	
		0	29.75	29.68	29.67	
	4.25	8	14.44	15.31	15.01	
155		15	1.54	1.20	1.36	
+00		0	29.71	29.65	29.64	
	3.50	8	14.39	15.28	14.97	
		15	1.50	1.17	1.32	

5.2. Transmitter output power in GPRS multislot configuration

<u>LIMIT</u>

ETSI TS 51.010-1 (V.10.2.0) Sub-clause 13.16.2.5

The transmitter output power is the average value of the power delivered to an artificial antenna or radiated by the MS and its integral antenna, over the time that the useful information bits of one burst are transmitted.

The transmitter output power, under every combination of normal and extreme test conditions, for normal bursts and access bursts, at each frequency and for each power control level applicable to the MS power class, shall be at the relevant level shown in table 13.16.2-1, table 13.16.2-2 or table 13.16.2-3 within the tolerances also shown in table 13.16.2-1, table 13.16.2-3.

Table 13.16.2-1: Bands	other than DCS	3 1800 and PCS	1900 transmitter	output power	for different power
<u>classes</u>					

P	Power class Power control		GAMMA TN	Transmitter	Tolera	ances		
				level (note 4)	(Гсн)	output power		
				, ,	(0.1.)	(note 2,3)		
2	3	4	5			dBm	normal	extreme
•				2	0	39	±2 dB	±2,5 dB
•	•			3	1	37	±3 dB (note 1)	±4 dB (note 1)
•	•			4	2	35	±3 dB	±4 dB
•	•	•		5	3	33	±3 dB (note 1)	±4 dB (note 1)
•	•	•		6	4	31	±3 dB	±4 dB
•	•	•	·	7	5	29	±3 dB (note 1)	±4 dB (note 1)
•	•	•	·	8	6	27	±3 dB	±4 dB
•	•	•	·	9	7	25	±3 dB	±4 dB
•	•	•	•	10	8	23	±3 dB	±4 dB
•	•	•	·	11	9	21	±3 dB	±4 dB
•	•	•	·	12	10	19	±3 dB	±4 dB
•	•	•	·	13	11	17	±3 dB	±4 dB
•	•	•	•	14	12	15	±3 dB	±4 dB
•	•	•	·	15	13	13	±3 dB	±4 dB
•	•	•	·	16	14	11	±5 dB	±6 dB
·	•	•	·	17	15	9	±5 dB	±6 dB
•	•	•	·	18	16	7	±5 dB	±6 dB
•	•	•	·	19	17	5	±5 dB	±6 dB
NOT	E1:	Whe	n the	power control leve	el corresponds to t	the power class of	f the MS, then the	tolerances shall
		be 2,	0 dB	under normal test	conditions and 2,	5 dB under extren	ne test conditions.	
NOT	E 2:	For F	899 a	nd Rel-4, the max	imum output powe	er in a multislot co	nfiguration must b	e lower within
		the li	mits d	lefined in table 13	.16.2-1a. From Re	el-5 onwards, the	maximum output p	power in a
	multislot configuration may be lower within the limits defined in table 13.16.2-1b.							
NOT	E 3:	For a	MS	using reduced inte	erslot dynamic ran	ge in multislot cor	ifigurations, the M	S may restrict
		the ir	nterslo	ot output power co	ontrol range to a 1	0 dB window, on a	a TDMA frame bas	sis. On those
		times	slots v	vhere the ordered	power level is mo	ore than 10 dB low	er than the applie	d power level of
		the highest power timeslot, the MS shall transmit at a lowest possible power level within 10 dB						
		range	e fron	n the highest appli	ed power level, if	not transmitting at	t the actual ordere	d power level.
NOT	E 4:	4: There is no requirement to test power control levels 20-31.						

Table 13.16.2-1a: R99 and Rel-4: Bands other than DCS 1800 and PCS 1900 allowed maximum output power reduction in a multislot configuration

Number of timeslots in uplink assignment	Permissible nominal reduction of maximum output power, (dB)
1	0
2	0 to 3,0
3	1,8 to 4,8
4	3,0 to 6,0

F	owe	er	Power control	GAMMA_IN	I ransmitter	Iolera	nces	
class			level (note 4)	(1 CH	(note 2.3)			
1	2	3			(note 2,3)	normal	extreme	
•	-	•	29	0	36	+2.0 dB	+2.5 dB	
			30	1	34	+3.0 dB	+4.0 dB	
			31	2	32	+3.0 dB	+4.0 dB	
			0	3	30	±3.0 dB	±4 dB	
						(note 1)	(note 1)	
-		-	1	4	28	`±3 dB ́	`±4 dB′	
•		•	2	5	26	±3 dB	±4 dB	
•	•	•	3	6	24	±3 dB	±4 dB	
						(note_1)	(note_1)	
•	•	•	4	7	22	±3 dB	±4 dB	
•	•	•	5	8	20	±3 dB	±4 dB	
•	•	•	6	9	18	±3 dB	±4 dB	
•	·	•	7	10	16	±3 dB	±4 dB	
•	·	•	8	11	14	±3 dB	±4 dB	
•	·	•	9	12	12	±4 dB	±5 dB	
•	·	•	10	13	10	±4 dB	±5 dB	
•	·	•	11	14	8	±4 dB	±5 dB	
·	·	·	12	15	6	±4 dB	±5 dB	
•	•	•	13	16	4	±4 dB	±5 dB	
•	·	•	14	17	2	±5 dB	±6 dB	
•	•	•	15	18	0	±5 dB	±6 dB	
NO	ΓE1:	W	nen the power con	trol level corresp	ponds to the powe	r class of the MS	S, then the	
		tole	erances shall be 2	,0 dB under nor	mai test conditions	s and 2,5 dB und	ter extreme	
NO	г г о.	tes	st conditions.			ultic let e e efier me	tion moved be	
NO	IE Z		r R99 and Rel-4, t	ne maximum ou	tput power in a mi	uitisiot configura		
			ver within the limits	s defined in table	e 13.10.2-28. F101	n Rel-5 onwards	, the limite	
		maximum output power in a multislot configuration may be lower within the limits						
	г – 2-		r a MS using radu	o.z-zp. ood intorelot dyn	omic rongo in mu	tielot configurati	ons the MS	
NO	1 - 3.	. FU	v restrict the inter	ceu intersiot dyr	arric range in mu	a 10 dB window		
		fra	me basis. On these	sioi ouipui powe	re the ordered nov	a to ub window	, on a TDIVIA than 10 dB	
			ver than the annlie	d nower level of	the highest nowe	r timeslot the M	S shall	
		tra	nsmit at a loweet r	ossible nower l	evel within 10 dR i	range from the h	iahest	
		an	nlied nower level	if not transmittin	a at the actual ord	lered nower leve		
NO	TE 4:	Th	ere is no requirem	ent to test powe	r control levels 16	-28.		

		Table 13.16.2-2: DCS1800	transmitter	output	power for	different	power	classes
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Table 13.16.2-2a: R99 and Rel-4: DCS 1 800 allowed maximum output power reduction in a multislot configuration

Number of timeslots in uplink assignment	Permissible nominal reduction of maximum output power, (dB)
1	0
2	0 to 3,0
3	1,8 to 4,8
4	3,0 to 6,0

TEST PROCEDURE

ETSI TS 51.010-1 (V.10.2.0) Sub-clause 13.16.2.4.2

a) Measurement of normal burst transmitter output power.

The SS takes power measurement samples evenly distributed over the duration of one burst with a sampling rate of at least 2/T, where T is the bit duration. The samples are identified in time with respect to the modulation on the burst. The SS identifies the centre of the useful 147 transmitted bits, i.e. the transition from bit 13 to bit 14 of the midamble, as the timing reference.

The transmitter output power is calculated as the average of the samples over the 147 useful bits. This is also used as the 0 dB reference for the power/time template.

- b) Measurement of normal burst power/time relationship The array of power samples measured in a) are referenced in time to the centre of the useful transmitted bits and in power to the 0 dB reference, both identified in 1.
- c) Steps 1 to 2 are repeated on each timeslot within the multislot configuration with the MS commanded to operate on each of the nominal output power levels defined in tables 13.16.2-1, 13.16.2-2 and 13.16.2-3, and in step a) only on one nominal output power higher than supported by the MS. NOTE: Power control levels 0 and 1 are excluded for bands other than DCS 1800 and PCS 1900 since these power control levels can not be set by GAMMA_TN.
- d) The SS commands the MS to the maximum power control level supported by the MS and steps a) to b) are repeated on each timeslot within the multislot configuration for ARFCN in the Low and High ranges.
- e) The SS commands the MS to the maximum power control level in the first timeslot allocated within the multislot configuration and to the minimum power control level in the second timeslot allocated. Any further timeslots allocated are to be set to the maximum power control level. Steps 1 to 2 and corresponding measurements on each timeslot within the multislot configuration are repeated.
- f) Measurement of access burst transmitter output power

The SS causes the MS to generate an Access Burst on an ARFCN in the Mid ARFCN range, this could be either by a cell re-selection or a new request for radio resource. In the case of a cell re-selection procedure the Power Level indicated in the PSI3 message is the maximum power control level supported by the MS. In the case of an Access Burst the MS shall use the Power Level indicated in the GPRS_MS_TXPWR_MAX_CCH parameter. If the power class of the MS is DCS 1 800 Class 3 and the Power Level is indicated by the MS_TXPWR_MAX_CCH parameter, the MS shall also use the POWER_OFFSET parameter.

The SS takes power measurement samples evenly distributed over the duration of the access burst as described in a). However, in this case the SS identifies the centre of the useful bits of the burst by identifying the transition from the last bit of the synch sequence. The centre of the burst is then five data bits prior to this point and is used as the timing reference. The transmitter output power is calculated as the average of the samples over the 87 useful bits of the burst. This is also used as the 0 dB reference for the power/time template.

- g) Measurement of access burst power/time relationship The array of power samples measured in f) is referenced in time to the centre of the useful transmitted bits and in power to the 0 dB reference, both identified in 5.
- h) Depending on the method used in step f) to cause the MS to send an Access Burst, the SS sends either a PACKET CELL CHANGE ORDER along with power control level set to 10 in PSI3 parameter GPRS_MS_TXPWR_MAX_CCH or it changes the (Packet) System Information elements (GPRS_)MS_TXPWR_MAX_CCH and for DCS 1 800 the POWER_OFFSET on the serving cell PBCCH/BCCH in order to limit the MS transmit power on the Access Burst to power control level 10 (+23 dBm for bands other than DCS 1800 and PCS 1900 or +10 dBm for DCS 1 800 and PCS 1 900) and then steps 5 to 6 are repeated.
- Steps a) to h) are repeated under extreme test conditions (annex 1, TC2.2) except that the repeats at step 3 are only performed for power control level 10 and the minimum nominal output power level supported by the MS.

TEST RESULTS

GPRS900							
Mod	le:	Slot: 1down4up; Coding scheme: CS-1					
Test envir	ronment	Dannan agartagi	Output Power (dBm)				
Temperature (℃)	Voltage (V)	Level	CH975	CH62	CH124		
		5	32.74	32.59	32.86		
25	3.70	12	19.63	19.47	19.52		
		19	5.21	5.36	5.65		
		5	32.85	32.65	32.94		
	4.25	12	19.74	19.53	19.60		
-10		19	5.30	5.41	5.71		
-10		5	32.83	32.64	32.92		
	3.50	12	19.71	19.52	19.58		
		19	5.29	5.40	5.70		
		5	32.64	32.53	32.79		
	4.25	12	19.55	19.42	19.46		
		19	5.13	5.32	5.60		
+00	3.50	5	32.60	32.51	32.76		
		12	19.50	19.40	19.43		
		19	5.09	5.29	5.56		
Mod	le:	Slot: 2down2up; Coding scheme: CS-1					
Test envir	ronment	Output Power (dBm)					
Temperature (℃)	Voltage (V)	Level	CH975	CH62	CH124		
		5	31.24	31.08	31.12		
25	3.70	12	18.24	18.05	18.14		
		19	4.06	4.29	4.17		
		5	31.33	31.13	31.18		
	4.25	12	18.32	18.10	18.20		
10		19	4.13	4.33	4.22		
-10		5	31.31	31.12	31.17		
	3.50	12	18.30	18.09	18.18		
		19	4.12	4.32	4.21		
		5	31.16	31.04	31.06		
	4.25	12	18.18	18.01	18.10		
		19	4.00	4.26	4.13		
+00		5	31.13	31.02	31.04		
	3.50	12	18.14	17.99	18.07		
		19	3.97	4.24	4.10		

GPRS1800							
Mod	le:	Slot: 1down4up; Coding scheme: CS-1					
Test envir	ronment		Output Power (dBm)				
Temperature (℃)	Voltage (V)	Level	CH512	CH698	CH885		
		0	29.64	29.73	29.42		
25	3.70	8	14.82	15.36	15.47		
		15	1.64	1.38	1.25		
		0	29.78	29.81	29.52		
	4.25	8	14.96	15.44	15.57		
10		15	1.76	1.45	1.33		
-10		0	29.75	29.79	29.50		
	3.50	8	14.92	15.42	15.54		
		15	1.74	1.43	1.32		
		0	29.55	29.68	29.36		
	4.25	8	14.75	15.32	15.42		
. 55		15	1.57	1.34	1.20		
+00	3.50	0	29.52	29.66	29.33		
		8	14.71	15.30	15.39		
		15	1.54	1.32	1.18		
Mod	le:	Slot: 2down2up; Coding scheme: CS-1					
Test envir	ronment	Output Power (dBm)					
Temperature (℃)	Voltage (V)	Level	CH512	CH698	CH885		
		0	28.15	28.36	28.47		
25	3.70	8	13.54	14.05	14.16		
		15	0.21	0.39	0.49		
		0	28.26	28.42	28.55		
	4.25	8	13.65	14.11	14.24		
10		15	0.30	0.44	0.55		
-10		0	28.23	28.41	28.53		
	3.50	8	13.62	14.10	14.22		
		15	0.28	0.43	0.54		
		0	28.08	28.32	28.42		
	4.25	8	13.49	14.02	14.12		
		15	0.16	0.36	0.45		
+55		0	28.06	28.31	28.40		
	3.50	8	13.45	14.00	14.10		
	0.00	15	0.13	0.34	0.43		

5.3. EGPRS Transmitter output power

LIMIT

ETSI TS 51.010-1 Sub-clause 13.17.3.5

The transmitter output power is the average value of the power delivered to an artificial antenna or radiated by the MS and its integral antenna, over the time that the useful information bits of one burst are transmitted. Since the conformance requirement, test procedure and test requirement of GSMK modulated signal's output power are defined in subclause 13.16.2 for GPRS MS, being thereby defined also for all EGPRS MS in that section, only 8PSK modulated signal's output power conformance requirement, test procedure and test requirement, test procedure and test requirements are defined in this subclause.

The transmitter output power for the 8-PSK modulated signals, under every combination of normal and extreme test conditions, for normal bursts, at each frequency and for each power control level applicable to the MS power class, shall be at the relevant level shown in table 13.17.3-1 or table 13.17.3-2 within the tolerances also shown in table 13.17.3-1 or table 13.17.3-2.

Power class			Power control	GAMMA_TN	Transmitter	Tolerances	
			level (note 3)	(Г _{сн})	output power		
					(note 1,2)		
E1	E2	E3					
•			2-5	0-3	33	±2 dB	±2.5dB
			6	4	31	±3 dB	±4 dB
			7	5	29	±3 dB	±4 dB
	•		8	6	27	±3 dB	±4 dB
	•		9	7	25	±3 dB	±4 dB
	•	•	10	8	23	±3 dB	±4 dB
	•	•	11	9	21	±3 dB	±4 dB
	•	•	12	10	19	±3 dB	±4 dB
	•	•	13	11	17	±3 dB	±4 dB
	•	•	14	12	15	±3 dB	±4 dB
	•	•	15	13	13	±3 dB	±4 dB
	•	•	16	14	11	±5 dB	±6 dB
	•	•	17	15	9	±5 dB	±6 dB
	•		18	16	7	±5 dB	±6 dB
	•	•	19	17	5	±5 dB	±6 dB

 Table 13.17.3-1: Bands other than DCS 1800 and PCS 1900 transmitter output power for different power classes 8PSK Modulated Signals

NOTE 2: For a MS using reduced interslot dynamic range in multislot configurations, the MS may restrict the interslot output power control range to a 10 dB window, on a TDMA frame basis. On those timeslots where the ordered power level is more than 10 dB lower than the applied power level of the highest power timeslot, the MS shall transmit at a lowest possible power level within 10 dB range from the highest applied power level, if not transmitting at the actual ordered power level.
 NOTE 3: There is no requirement to test power control levels 20-31.

Table 13.17.3-1a: R99 and Rel-4: Bands other than DCS 1800 and PCS 1900 allowed maximum output

power reduction in a manusion configuration					
Number of	Permissible nominal				
timeslots in uplink	reduction of maximum				
assignment	output power, (dB)				
1	0				
2	0 to 3,0				
3	1,8 to 4,8				
4	3,0 to 6,0				

nower reduction in a multislat configuration

NOTE 1: For R99 and Rel-4, the maximum output power in a multislot configuration must be lower within the limits defined in table 13.17.3-1a. From Rel-5 onwards, the maximum output power in a multislot configuration may be lower within the limits defined in table 13.17.3-1b.

 Table 13.17.3-1b: From Rel-5 onwards: Bands other than DCS 1800 and PCS 1900 allowed maximum output power reduction in a multislot configuration

Number of timeslots in uplink assignment	Permissible nominal reduction of maximum output power, (dB)			
1	0			
2	3,0			
3	4,8			
4	6,0			
5	7,0			
6	7,8			
7	8,5			
8	9,0			

 Table 13.17.3-2: DCS 1 800 and PCS 1 900 transmitter output power for different power classes 8-PSK

 Modulated Signals

Power class		ass	Power control	GAMMA TN	Transmitter	Tolerances	
i ower elass			level (note 3)	(Гсч)	output power		
				(1 CH)	(note 1.2)		
F 4	_	F 2				NODMAL	EVTDEME
El	E2	E3				NORMAL	EXIREME
· ·			29,0 *)	0-3 **)	30	±3 dB(1000 4)	±4dB ^(note 4)
			1	4	28	±3 dB	±4 dB
	•		2	5	26	±3 dB ^(note 4)	±4 dB ^(note 4)
	•		3	6	24	±3 dB	±4 dB
	•		4	7	22	±3 dB	±4 dB
	•	•	5	8	20	±3 dB	±4 dB
			6	9	18	±3 dB	±4 dB
	•	•	7	10	16	±3 dB	±4 dB
	•		8	11	14	±4 dB	±4 dB
			9	12	12	±4 dB	±5 dB
	•	•	10	13	10	±4 dB	±5 dB
			11	14	8	±4 dB	±5 dB
	•		12	15	6	±4 dB	±5 dB
			13	16	4	±5 dB	±5 dB
	•		14	17	2	±5 dB	±6 dB
	•		15	18	0	±5 dB	±6 dB
*> 20	0 4		4000 **\ 4 2 fam DC	0 1000			

*) 30-0 for PCS 1900 **) 1-3 for PCS 1900

NOTE 1: For R99 and Rel-4, the maximum output power in a multislot configuration must be lower within the limits defined in table 13.17.3-2a. From Rel-5 onwards, the maximum output power in a multislot configuration may be lower within the limits defined in table 13.17.3-2b.

NOTE 2: For a MS using reduced interslot dynamic range in multislot configurations, the MS may restrict the interslot output power control range to a 10 dB window, on a TDMA frame basis. On those timeslots where the ordered power level is more than 10 dB lower than the applied power level of the highest power timeslot, the MS shall transmit at a lowest possible power level within 10 dB range from the highest applied power level, if not transmitting at the actual ordered power level.

- NOTE 3: There is no requirement to test power control levels 16-28.
- NOTE 4: When the power control level corresponds to the power class of the MS, then the tolerances shall be ±2,0 dB under normal test conditions and ±2,5 dB under extreme test conditions for a class E1 mobile. For a class E2 mobile the tolerances shall be -4/+3 under normal test conditions and -4,5/+4 dB under extreme test conditions.

 Table 13.17.3-2a: R99 and Rel-4: DCS 1 800 and PCS 1 900 allowed maximum output power reduction in a multislot configuration

g					
Number of	Permissible nominal				
timeslots in uplink	reduction of maximum				
assignment	output power, (dB)				
1	0				
2	0 to 3,0				
3	1,8 to 4,8				
4	3,0 to 6,0				

 Table 13.17.3-2b: From Rel-5 onwards: DCS 1 800 and PCS 1 900 allowed maximum output power reduction in a multislot configuration

Number of timeslots in uplink assignment	Permissible nominal reduction of maximum output power, (dB)
1	0
2	3,0
3	4,8
4	6,0
5	7,0
6	7,8
7	8,5
8	9,0

TEST PROCEDURE

ETSI TS 51.010-1 Sub-clause 13.17.3.4.2

- a) Measurement of normal burst transmitter output power
 For 8PSK, power may be determined by applying the technique described for GMSK in subclause
 13.16.2.4.1.2; step a) and then averaging over multiple bursts to achieve sufficient accuracy (see annex
 5). Alternatively, an estimation technique based on a single burst which can be demonstrated to yield the same result as the long term average may be used. The long term average or the estimate of long term average is used as the 0dB reference for the power/time template.
- b) Measurement of normal burst power/time relationship. The array of power samples measured in a) are referenced in time to the centre of the useful transmitted symbols and in power to the 0 dB reference, both identified in a).
- c) Steps a) to b) are repeated on each timeslot within the multislot configuration with the MS commanded to operate on each of the nominal output power levels defined in tables 13.17.3-1, 13.17.3-2 and 13.17.3-3. NOTE: Power control levels 0 and 1 are excluded for bands other than DCS 1800 and PCS 1900 since these power control levels can not be set by GAMMA_TN.
- d) The SS commands the MS to the maximum power control level supported by the MS and steps a) to b) are repeated on each timeslot within the multislot configuration for ARFCN in the Low and High ranges.
- e) The SS commands the MS to the maximum power control level in the first timeslot allocated within the multislot configuration and to the minimum power control level in the second timeslot allocated. Any further timeslots allocated are to be set to the maximum power control level. Steps a) to b) and corresponding measurements on each timeslot within the multislot configuration are repeated. This step is only applicable to MS which support more than one uplink time slot.
- f) Steps a) to e) are repeated under extreme test conditions (annex 1, TC2.2) except that the repeats at step c) are only performed for power control level 10 and the minimum nominal output power level supported by the MS.

TEST RESULTS

EGPRS900							
Moc	le:	Slot: 1down4up; Coding scheme: CS-1					
Test envir	onment	Dannan agartagi	Output Power (dBm)				
Temperature (℃)	Voltage (V)	Level	CH975	CH62	CH124		
		5	32.69	32.47	32.85		
25	3.70	12	19.36	19.47	19.84		
		19	5.39	5.42	5.63		
		5	32.80	32.55	32.94		
	4.25	12	19.47	19.54	19.93		
-10		19	5.48	5.48	5.70		
10		5	32.78	32.53	32.92		
	3.50	12	19.44	19.53	19.91		
		19	5.47	5.47	5.69		
		5	32.59	32.40	32.77		
	4.25	12	19.28	19.41	19.77		
. 55		19	5.31	5.37	5.57		
-55		5	32.55	32.37	32.73		
	3.50	12	19.23	19.38	19.74		
		19	5.27	5.34	5.53		
Moc	le:	Slot: 2down2up; Coding scheme: CS-1					
Test envir	ronment	Deuver eentrel)				
Temperature (℃)	Voltage (V)	Level	CH975	CH62	CH124		
		5	31.08	31.47	31.52		
25	3.70	12	18.34	18.52	18.33		
		19	4.32	4.08	4.52		
		5	31.21	31.56	31.62		
	4.25	12	18.46	18.60	18.43		
10		19	4.42	4.15	4.60		
-10		5	31.17	31.53	31.60		
	3.50	12	18.43	18.58	18.40		
		19	4.40	4.14	4.59		
		5	30.97	31.40	31.43		
	4.25	12	18.25	18.46	18.26		
		19	4.24	4.02	4.45		
+00		5	30.93	31.37	31.40		
	3.50	12	18.20	18.43	18.22		
	0.00	19	4.19	3.99	4.41		

EGPRS1800					
Mode:		Slot: 1down4up; Coding scheme: CS-1			
Test environment		Output Power (dBm))
Temperature (℃)	Voltage (V)	Level	CH512	CH698	CH885
25	3.70	0	29.48	29.76	29.52
		8	14.85	15.36	15.47
		15	1.69	1.47	1.52
	4.25	0	29.63	29.86	29.64
		8	14.99	15.45	15.58
10		15	1.81	1.55	1.61
-10		0	29.59	29.83	29.61
	3.50	8	14.95	15.43	15.55
		15	1.79	1.54	1.60
	4.25	0	29.39	29.70	29.45
		8	14.78	15.31	15.41
		15	1.62	1.42	1.47
+55	3.50	0	29.36	29.68	29.42
		8	14.74	15.28	15.38
		15	1.59	1.40	1.43
Mode:		Slot: 2down2up; Coding scheme: CS-1			
Test environment		Output Power (dBm))
Temperature (℃)	Voltage (V)	Level	CH512	CH698	CH885
25	3.70	0	28.46	28.25	28.64
		8	13.46	14.08	14.15
		15	0.06	0.25	0.47
-10	4.25	0	28.58	28.33	28.74
		8	13.57	14.16	14.24
		15	0.15	0.31	0.55
	3.50	0	28.55	28.31	28.71
		8	13.54	14.14	14.22
		15	0.14	0.30	0.53
+55	4.25	0	28.37	28.19	28.56
		8	13.39	14.03	14.09
		15	-0.01	0.20	0.41
	3.50	0	28.33	28.16	28.53
		8	13.34	14.00	14.05
		15	-0.05	0.17	0.38

5.4. Radiated spurious emissions-MS Allocated a channel

<u>LIMIT</u>

ETSI TS 51.010-1 Sub-clause 12.2.1.5

	Power level in dBm		
Frequency range	GSM900	DCS1800	
30MHz to 1GHz	-36	-36	
1GHz to 4GHz	-30	-	
1GHz to 1710MHz	-	-30	
1710MHz to 1785MHz	-	-36	
1785MHz to 4GHz	-	-30	

TEST CONFIGURATION





TEST PROCEDURE

ETSI TS 51.010-1 Sub-clause 12.2.1.4.2

- a) Initially the test antenna is closely coupled to the MS and any spurious emission radiated by the MS is detected by the test antenna and receiver in the range 30 MHz to 4 GHz.
 NOTE 1: This is a qualitative step to identify the frequency and presence of spurious emissions which are to be measured in subsequent steps.
- b) The test antenna separation is set to the appropriate measurement distance and at each frequency at which a spurious emission has been detected the MS is rotated to obtain a maximum response. The effective radiated power of the emission is determined by a substitution measurement. In case of an anechoic shielded chamber pre-calibration may be used instead of a substitution measurement.
- c) The measurement bandwidth based on a 5 pole synchronously tuned filter shall be according to table 8. The power indication is the peak power detected by the measuring system. The measurement time on any frequency shall be such that it includes the time during which the MS.

The measurement time on any frequency shall be such that it includes the time during which the MS receives a TDMA frame containing the paging channel

NOTE 2: For these filter bandwidths some difficulties may be experienced with noise floor above required measurement limit. This will depend on the gain of the test antenna, and adjustment of the measuring system bandwidth is permissible. Alternatively, for test frequencies above 900 MHz, the test antenna separation from the MS may be reduced to 1 meter.

The measurements are repeated with the test antenna in the orthogonal polarization plane.d) The test is repeated under extreme voltage test conditions (see [Annex 1, TC2.2]).

Frequency range	Frequency offset	Filter bandwidth	Approx video bandwidth
30MHz to 50MHz	-	10KHz	30KHz
50MHz to 500MHz	-	100KHz	300KHz
500MHz to 12.75GHz	0 to 10MHz ≥10MHz ≥20MHz ≥30MHz	100KHz 300KHz 1MHz 3MHz	300KHz 1MHz 3MHz 3MHz

TEST RESULTS

This test was carried out in all the test modes, here only the worst test result was shown.at GSM900

The EUT has met the requirements of 3GPP2 C.S0011-A's requirement.





Note: The radiated spurious are performed the each test Voltage mode, the datum recorded is the worst case for all the mode at Normal Voltage type.

5.5. Radiated spurious emissions- MS in Idle Channel

<u>LIMIT</u>

ETSI TS 51.010-1 Sub-clause 12.2.2.5

Frequency range	Limit (dBm)
9KHz to 880MHz	-57
880MHz to 915MHz	-59
915MHz to 1000MHz	-57
1GHz to 1710MHz	-47
1710MHz to 1785MHz	-53
1785MHz to 12.75GHz	-47

TEST CONFIGURATION





TEST PROCEDURE

ETSI TS 51.010-1 Sub-clause 12.2.2.4.2

- a) Initially the test antenna is closely coupled to the MS and any spurious emission radiated by the MS is detected by the test antenna and receiver in the range 30 MHz to 4 GHz.
 NOTE 1: This is a qualitative step to identify the frequency and presence of spurious emissions which are to be measured in subsequent steps.
- b) The test antenna separation is set to the appropriate measurement distance and at each frequency at which a spurious emission has been detected the MS is rotated to obtain a maximum response. The effective radiated power of the emission is determined by a substitution measurement. In case of an anechoic shielded chamber pre-calibration may be used instead of a substitution measurement.

c) The measurement bandwidth based on a 5 pole synchronously tuned filter shall be according to table 8. The power indication is the peak power detected by the measuring system. The measurement time on any frequency shall be such that it includes the time during which the MS receives a TDMA frame containing the paging channel NOTE 2: For these filter bandwidths some difficulties may be experienced with noise floor above required

NOTE 2: For these filter bandwidths some difficulties may be experienced with noise floor above required measurement limit. This will depend on the gain of the test antenna, and adjustment of the measuring system bandwidth is permissible. Alternatively, for test frequencies above 900 MHz, the test antenna separation from the MS may be reduced to 1 meter.

- d) The measurements are repeated with the test antenna in the orthogonal polarization plane.
- e) The test is repeated under extreme voltage test conditions (see [Annex 1, TC2.2]).

Frequency range	Filter bandwidth	Video bandwidth	
100KHz to 50MHz	10KHz	30KHz	
50MHz to 12.75GHz	100KHz	300KHz	

TEST RESULTS

This test was carried out in all the test modes, here only the worst test result was shown.at GSM900

The EUT has met the requirements of 3GPP2 C.S0011-A's requirement.





Note: The radiated spurious are performed the each test Voltage mode, the datum recorded is the worst case for all the mode at Normal Voltage type.

6. Test Setup Photos of the EUT



7. External and Internal Photos of the EUT

External photos of the EUT











Internal photos of the EUT











-----End of Report-----